

**Search Notes**

Application/Control No.

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Examiner

Dennis-Doon Chow

Applicant(s)/Patent under  
Reexamination

HSIEH, YOU-JUN

Art Unit

2677

**SEARCHED**

Class	Subclass	Date	Examiner
345	156	3/15/2006	CHOW
	168-172		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR